May 2003



FDP6670AL/FDB6670AL

N-Channel Logic Level PowerTrench^o MOSFET

General Description

This N-Channel Logic Level MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

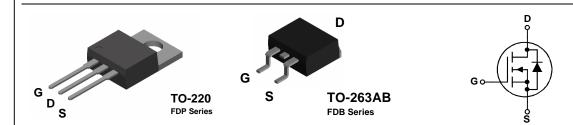
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

It has been optimized for low gate charge, low $R_{\text{DS}(\text{ON})}$ and fast switching speed.

Features

- 80 A, 30 V $R_{DS(ON)} = 6.5 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 8.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Critical DC electrical parameters specified at elevated temperature
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- 175°C maximum junction temperature rating



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		± 20	V
ID	Drain Current – Continuous	(Note 1)	80	А
	- Pulsed	(Note 1)	240	
P _D	Total Power Dissipation @ T _c = 25°C Derate above 25°C		68	W
			0.45	W/°C
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-65 to +175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.2	°C/W
R _{0JA} Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDB6670AL	FDB6670AL	13"	24mm	800 units
FDP6670AL	FDP6670AL	Tube	n/a	45

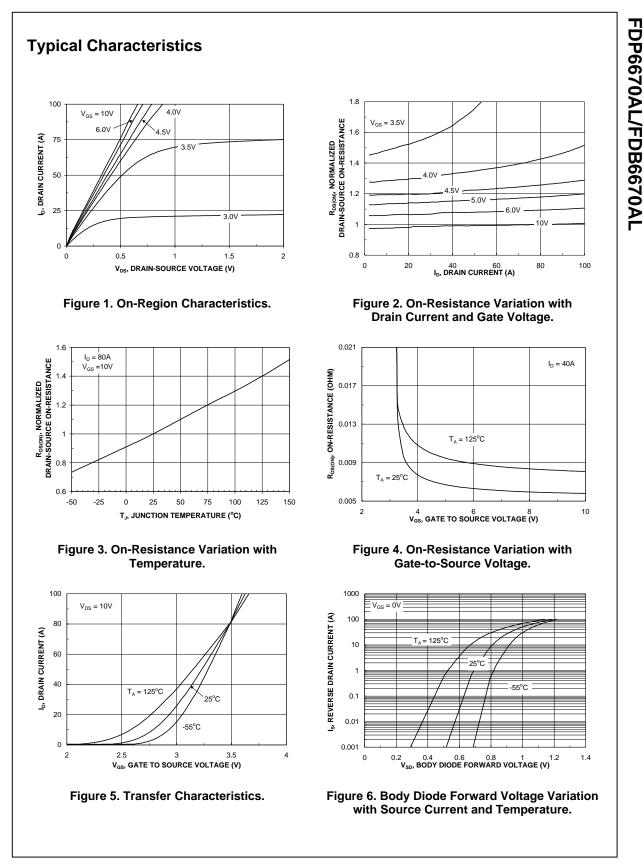
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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Symbol	Falameter	Test conditions		тур	WIAX	Units
Drain-Sc	purce Avalanche Ratings (Note					
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 15 \text{ V}, \qquad I_D = 80 \text{ A}$			114	mJ
AR	Maximum Drain-Source Avalanche Current				80	A
Off Char	acteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS}=0~V, \qquad I_D=250~\mu A$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25° C		24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, \qquad V_{\text{GS}} = 0 \text{ V}$			1	μA
I _{GSS}	Gate–Body Leakage	$V_{GS}=\pm~20~V,~~V_{DS}=0~V$			± 100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1	1.9	3	V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-5		mV/°C
R _{DS(on)}	Static Drain–Source On– Resistance			5.2 6.5 7.2	6.5 8.5 9.7	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$	80		0.1	А
g _{FS}	Forward Transconductance	$V_{DS} = 10V, I_D = 40 A$		115		S
-						-
	Characteristics			2440		pF
	Output Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$, f = 1.0 MHz		580		pr pF
C _{rss}	Reverse Transfer Capacitance			250		pF
R _G	Gate Resistance	$V_{GS} = 15 \text{ mV}, f = 1.0 \text{ MHz}$		1.4		Ω
Switchin	g Characteristics (Note 2)			I		1
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 10V,$ $I_{D} = 1 A,$		13	23	ns
t _r	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		13	23	ns
t _{d(off)}	Turn–Off Delay Time			42	68	ns
t _f	Turn–Off Fall Time			15	27	ns
Q _g	Total Gate Charge	$V_{DS} = 15 V, I_D = 40 A,$		24	33	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 5 V$		7		nC
Q _{gd}	Gate-Drain Charge			9		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				80	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 40 A$ (Note 1)		0.9	1.3	V
t _{rr}	Diode Reverse Recovery Time	I _F = 40 A,		34		nS
Q _{rr}	Diode Reverse Recovery Charge	d _{iF} /d _t = 100 A/μs		24		nC

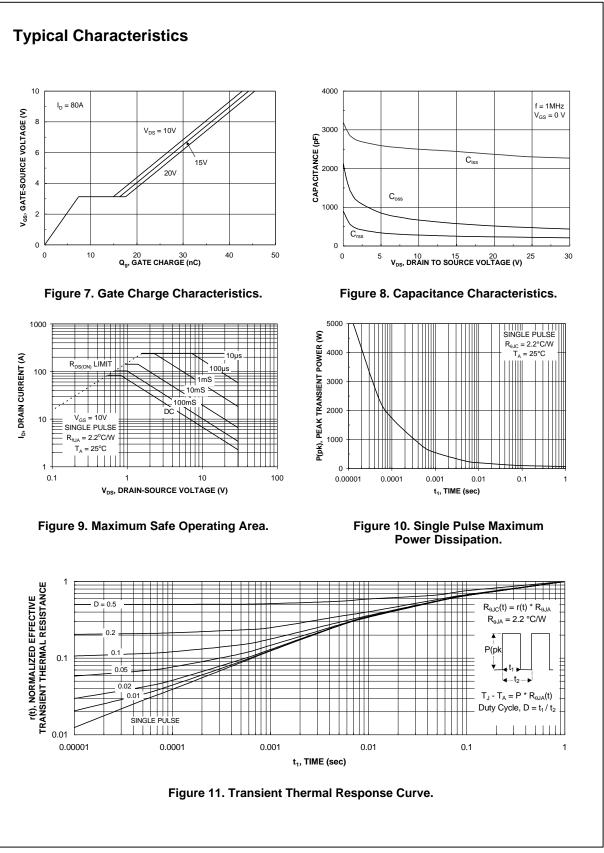
Notes:

1. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

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FDP6670AL/FDB6670AL Rev D(W)



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